Standardized Information for Process/Product Change Notification (PCN)

	Name Customer:		Digi-key Corporation			
Customer		Contact Email address:		DigiKey.SupplierInfo@digikey.com		ey.com
		Site submitting the change:		Melexis Belgium		
	Melexis INSPIRED ENGINEERING	Affected site:	Melexis :	Supplier	Melexis Corbeil	
1.1 Company						
1.3 Title of PC	N	Active Second Source				
1.4 Product Category		Active Components - Integrated Circuits				
1.5 Issue date		Jan 5 2018				

2. PCN Team			
2.1 Contact supplier			
2.1.1 Phone	+3257226142		
2.1.2 Email	contact-PCN@melexis.com		

3. Changes				
No.	3.0 Ident	3.1 Category	3.2 Type of change	
#1	SEM-PW-13	IPROCESS - WAFER PRODUCTION	Move of all or part of wafer fab to a different location/site/subcontractor	
#2	SEM-TF-01		Move of all or part of electrical wafer test and/or final test to a different location/site/subcontractor	

4. Description of change			
	Old	New	
Change #1	IVV ater tan legation. X-tan Kilching (Zarawak / IVIalavkia)	Wafer fab location: X-fab Corbeil (France / Europe) + X-fab Kuching (Sarawak / Malaysia)	
Change #2	rejectrical mater test location, crittently teleased locations	Electrical wafer test location: currently released locations + Melexis Corbeil	

5. Reason / motivation for change			
5.1 Motivation	As a responsible and future oriented player, Melexis is protecting it's customers. This includes to secure the supply chain against environmental and/or material based events (contingency plan). The increase in business leads to wafer demand beyond X-Fab Kuching capability.		

6. Marking of parts / traceability of change			
6.1 Description	Lots produced at Xfab Corbeil will have a different lot ID-number. The first letter of the lot ID will start with "F".		

7. Timing / schedule			
7.1 Date of qualification results	End Q4 2018		
7.2 Intended start of delivery	End of Q1 2019		
7.3 Qualification samples available?	Yes, on request		

8. Qualification / validation			
8.1 Description (e.g. qual. plan/report,	Available as end of Q4 2018		
8.2 Qualification report and qualificati	Available as of January 2019		

9. Input to customer for risk assessment process Second source is needed to avoid capacity constraints regarding wafer material supply and test throughput

10. Attachments (e.g. new datasheet, additional documentation, pictures, process flow, sample plan, ...)

See presentation: XFabTransfer_Corbeil.pdf

11. Affected parts				
11.1 Current			11.2 New (if applicable)	
11.1.1				
Customer			11.2.2 Supplier Part	
Part No.	11.1.2 Supplier Part Name	11.1.3 Package Name	Name	11.2.4 Package Name
NA	MLX81106KDC-CAA-000-RE	SOIC8 GR		
NA	MLX81107KLW-CAE-000-RE	QFN_WF20/5x5 GR		
NA	MLX81108KDC-CAE-000-RE	SOIC8 GR		